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Safety of machinery - Electro-sensitive protective equipment Part 3: Particular requirements for active opto-electronic protective devices responsive to diffuse reflection (AOPDDR)

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IEC Secretariat Tel.: +41 22 919 02 11

3, rue de Varembé info@iec.ch CH-1211 Geneva 20 www.iec.ch

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

Safety of machinery - Electro-sensitive protective equipment Part 3: Particular requirements for active opto-electronic protective devices responsive to diffuse reflection (AOPDDR)

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This commented version (CMV) of the official standard IEC 61496-3:2025 edition 4.0 allows the user to identify the changes made to the previous IEC 61496-3:2018 edition 3.0. Furthermore, comments from IEC TC 44 experts are provided to explain the reasons of the most relevant changes, or to clarify any part of the content.

A vertical bar appears in the margin wherever a change has been made. Additions are in green text, deletions are in strikethrough red text. Experts' comments are identified by a blue-background number. Mouse over a number to display a pop-up note with the comment.

This publication contains the CMV and the official standard. The full list of comments is available at the end of the CMV.

IEC 61496-3 has been prepared by IEC technical committee 44: Safety of machinery – Electrotechnical aspects. It is an International Standard.

This fourth edition cancels and replaces the third edition published in 2018. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) some requirement clauses and test procedures have been adapted or removed because they have been consolidated in IEC 61496-1:2020 (e.g. 5.4.6.2 Light sources and Clause A.9);
- b) change of the minimum probability of detection and fault detection requirements for Type 2 AOPDDR:
- c) using the AOPDDR as a trip device is described as an optional function in Clause A.13.

The text of this International Standard is based on the following documents:

Draft	Report on voting
44/1061/FDIS	44/1065/RVD

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

This document is to be used in conjunction with IEC 61496-1:2020.

The language used for the development of this International Standard is English.

A list of all parts in the IEC 61496 series, published under the general title Safety of machinery – Electro-sensitive protective equipment, can be found on the IEC website.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/publications.

This document supplements or modifies the corresponding clauses in IEC 61496-1:2020 to specify particular requirements for the design, construction and testing of electro-sensitive protective equipment (ESPE) for the safeguarding of machinery, employing active opto-electronic protective devices responsive to diffuse reflection (AOPDDR) for the sensing function.

Where a particular clause or subclause of IEC 61496-1:2020 is not mentioned in this document, that clause or subclause applies as far as is reasonable. Where this document states "addition" or "replacement", the relevant text of IEC 61496-1:2020 is adapted accordingly.

Clauses and subclauses which are additional to those of IEC 61496-1:2020 are numbered sequentially, following on the last available number in IEC 61496-1:2020. Terminological entries (in Clause 3) which are additional to those in IEC 61496-1:2020 are numbered starting from 3.301. Additional annexes are lettered from AA onwards.